UNITRODE

UC1824
UC2824
UC3824

High Speed PWM Controller

FEATURES

- Complementary Outputs
- Practical Operation Switching Frequencies to 1MHz
- 50ns Propagation Delay to Output
- High Current Dual Totem Pole Outputs (1.5A Peak)
- Wide Bandwidth Error Amplifier
- Fully Latched Logic with Double Pulse Suppression
- Pulse-by-Pulse Current Limiting
- Soft Start / Max. Duty Cycle Control
- Under-Voltage Lockout with Hysteresis
- Low Start Up Current (1.1 mA)
- Trimmed Bandgap Reference (5.1V ± 1%)

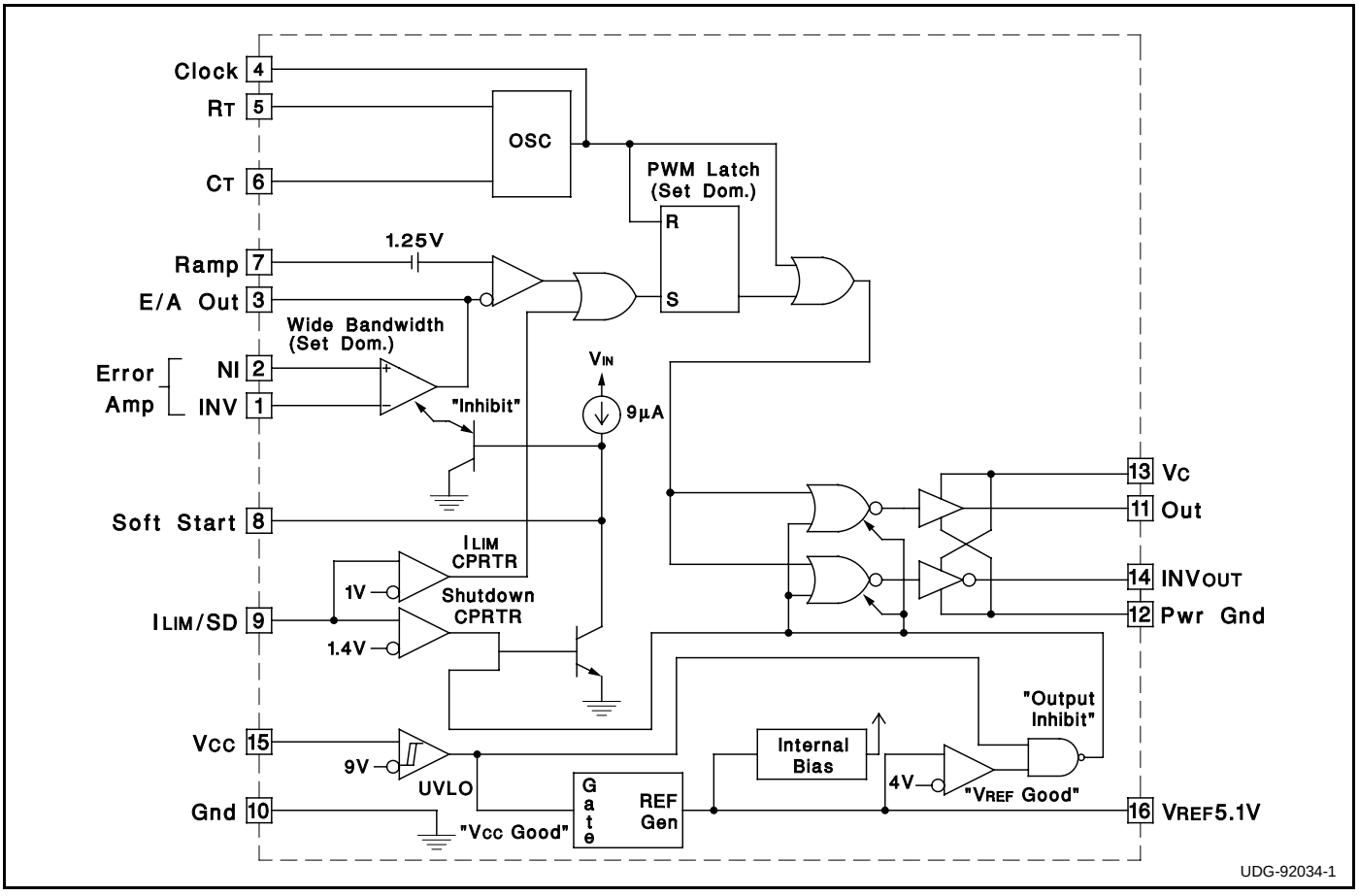
DESCRIPTION

The UC1824 family of PWM control ICs is optimized for high frequency switched mode power supply applications. Particular care was given to minimizing propagation delays through the comparators and logic circuitry while maximizing bandwidth and slew rate of the error amplifier. This controller is designed for use in either current-mode or voltage mode systems with the capability for input voltage feed-forward.

Protection circuitry includes a current limit comparator with a 1V threshold, a TTL compatible shutdown port, and a soft start pin which will double as a maximum duty cycle clamp. The logic is fully latched to provide jitter free operation and prohibit multiple pulses at an output. An under-voltage lockout section with 800mV of hysteresis assures low start up current. During under-voltage lockout, the outputs are high impedance.

These devices feature totem pole outputs designed to source and sink high peak currents from capacitive loads, such as the gate of a power MOSFET. The on state is designed as a high level.

BLOCK DIAGRAM



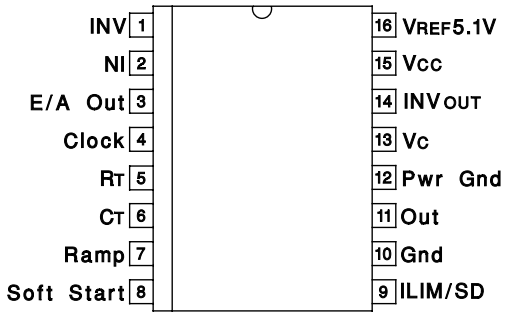
ABSOLUTE MAXIMUM RATINGS (Note 1)

Supply Voltage (Pins 13, 15) 30V
Output Current, Source or Sink (Pins 11, 14)
DC. 0.5A
Pulse (0.5µs) 2.0A
Analog Inputs
(Pins 1, 2, 7) . . . . . -0.3V to 7V
(Pin 8, 9) . . . . . -0.3V to 6V
Clock Output Current (Pin 4) . . . . . -5mA
Error Amplifier Output Current (Pin 3) 5mA
Soft Start Sink Current (Pin 8) 20mA
Oscillator Charging Current (Pin 5) . . . . . -5mA
Power Dissipation 1W
Storage Temperature Range . . . . . -65°C to +150°C
Lead Temperature (Soldering, 10 seconds) . . . . . 300°C

Note 1: All voltages are with respect to GND (Pin 10); all currents are positive into, negative out of part; pin numbers refer to DIL-16 package.

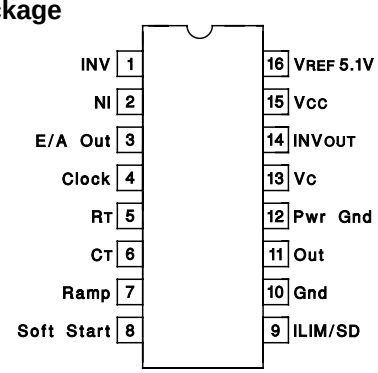
Note 3: Consult Unitrode Integrated Circuit Databook for thermal limitations and considerations of package.

SOIC-16 (Top View)
DW Package

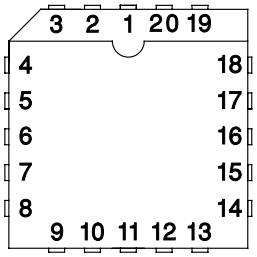


CONNECTION DIAGRAMS

DIL-16 (Top View)
J Or N Package



PLCC-20 & LCC-20
(Top View)
Q & L Packages



PACKAGE PIN FUNCTION	
FUNCTION	PIN
N/C	1
INV	2
NI	3
E/A Out	4
Clock	5
N/C	6
RT	7
CT	8
Ramp	9
Soft Start	10
N/C	11
ILIM/SD	12
Gnd	13
Out	14
Pwr Gnd	15
N/C	16
VC	17
INVOUT	18
VCC	19
VREF 5.1V	20

ELECTRICAL CHARACTERISTICS:

Unless otherwise stated,these specifications apply for , R_T = 3.65k, C_T = 1nF, V_{CC} = 15V, -55°C<T_A<125°C for the UC1824, –40°C<T_A<85°C for the UC2824, and 0°C<T_A<70°C for the UC3824, T_A=T_J.

PARAMETERS	TEST CONDITIONS	UC1824 UC2824			UC3824			UNITS
		MIN	TYP	MAX	MIN	TYP	MAX	
Reference Section								
Output Voltage	T_J = 25°C, I_O = 1mA	5.05	5.10	5.15	5.00	5.10	5.20	V
Line Regulation	10V < V_{CC} < 30V		2	20		2	20	mV
Load Regulation	1mA < I_O < 10mA		5	20		5	20	mV
Temperature Stability*	T_{MIN} < T_A < T_{MAX}		0.2	0.4		0.2	0.4	mV/°C
Total Output Variation*	Line, Load, Temperature	5.00		5.20	4.95		5.25	V
Output Noise Voltage*	10Hz < f < 10kHz		50			50		µV
Long Term Stability*	T_J = 125°C, 1000hrs.		5	25		5	25	mV
Short Circuit Current	V_{REF} = 0V	-15	-50	-100	-15	-50	-100	mA
Oscillator Section								
Initial Accuracy*	T_J = 25°C	360	400	440	360	400	440	kHz
Voltage Stability*	10V < V_{CC} < 30V		0.2	2		0.2	2	%
Temperature Stability*	T_{MIN} < T_A < T_{MAX}		5			5		%
Total Variation*	Line, Temperature	340		460	340		460	kHz

ELECTRICAL CHARACTERISTICS (cont.)

Unless otherwise stated,these specifications apply for , R_T = 3.65k, C_T = 1nF, V_{CC} = 15V, -55°C<T_A<125°C for the UC1824, –40°C<T_A<85°C for the UC2824, and 0°C<T_A<70°C for the UC3824, T_A=T_J.

PARAMETERS	TEST CONDITIONS	UC1824 UC2824			UC3824			UNITS
		MIN	TYP	MAX	MIN	TYP	MAX	
Oscillator Section (cont.)								
Clock Out High		3.9	4.5		3.9	4.5		V
Clock Out Low			2.3	2.9		2.3	2.9	V
Ramp Peak*		2.6	2.8	3.0	2.6	2.8	3.0	V
Ramp Valley*		0.7	1.0	1.25	0.7	1.0	1.25	V
Ramp Valley to Peak*		1.6	1.8	2.0	1.6	1.8	2.0	V
Error Amplifier Section								
Input Offset Voltage				10			15	mV
Input Bias Current			0.6	3		0.6	3	µA
Input Offset Current			0.1	1		0.1	1	µA
Open Loop Gain	1V < V_O < 4V	60	95		60	95		dB
CMRR	1.5V < V_{CM} < 5.5V	75	95		75	95		dB
PSRR	10V < V_{CC} < 30V	85	110		85	110		dB
Output Sink Current	$V_{PIN\ 3}$ = 1V	1	2.5		1	2.5		mA
Output Source Current	$V_{PIN\ 3}$ = 4V	-0.5	-1.3		-0.5	-1.3		mA
Output High Voltage	$I_{PIN\ 3}$ = -0.5mA	4.0	4.7	5.0	4.0	4.7	5.0	V
Output Low Voltage	$I_{PIN\ 3}$ = 1mA	0	0 .5	1.0	0	0.5	1.0	V
Unity Gain Bandwidth*		3	5.5		3	5.5		MHz
Slew Rate*		6	12		6	12		V/µs
PWM Comparator Section								
Pin 7 Bias Current	$V_{PIN\ 7}$ = 0V		-1	-5		-1	-5	µA
Duty Cycle Range		0		80	0		85	%
Pin 3 Zero DC Threshold	$V_{PIN\ 7}$ = 0V	1.1	1.25		1.1	1.25		V
Delay to Output*			50	80		50	80	ns
Soft-Start Section								
Charge Current	$V_{PIN\ 8}$ = 0.5V	3	9	20	3	9	20	µA
Discharge Current	$V_{PIN\ 8}$ = 1V	1			1			mA
Current Limit / Shutdown Section								
Pin 9 Bias Current	0 < $V_{PIN\ 9}$ < 4V			15			10	µA
Current Limit Threshold		0.9	1.0	1.1	0.9	1.0	1.1	V
Shutdown Threshold		1.25	1.40	1.55	1.25	1.40	1.55	V
Delay to Output			50	80		50	80	ns
Output Section								
Output Low Level	I_{OUT} = 20mA		0.25	0.40		0.25	0.40	V
	I_{OUT} = 200mA		1.2	2.2		1.2	2.2	V
Output High Level	I_{OUT} = -20mA	13.0	13.5		13.0	13.5		V
	I_{OUT} = -200mA	12.0	13.0		12.0	13.0		V
Collector Leakage	V_C = 30V		100	500		10	500	µA
Rise/Fall Time*	CL = 1nF		30	60		30	60	ns
Under-Voltage Lockout Section								
Start Threshold		8.8	9.2	9.6	8.8	9.2	9.6	V
UVLO Hysteresis		0.4	0.8	1.2	0.4	0.8	1.2	V
Supply Current Section								
Start Up Current	V_{CC} = 8V		1.1	2.5		1.1	2.5	mA
ICC	$V_{PIN\ 1}$, $V_{PIN\ 7}$, $V_{PIN\ 9}$ = 0V; $V_{PIN\ 2}$ = 1V		22	33		22	33	mA

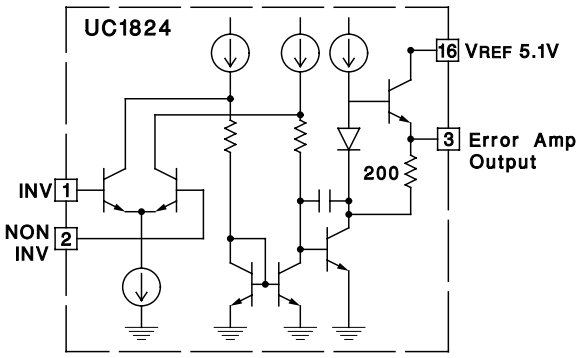
** This parameter not 100% tested in production but guaranteed by design.*

UC1824 Printed Circuit Board Layout Considerations

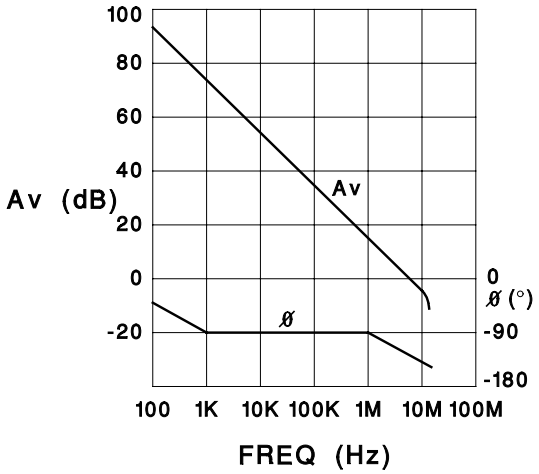
High speed circuits demand careful attention to layout and component placement. To assure proper performance of the UC1824 follow these rules: 1) Use a ground plane. 2) Damp or clamp parasitic inductive kick energy from the gate of driven MOSFETs. Do not allow the output pins to ring below ground. A series gate resistor or a shunt 1 Amp Schottky diode at the output pin will serve this purpose. 3) Bypass V_{CC}, V_C, and V_{REF}. Use 0.1µF monolithic ceramic capacitors with low equivalent series inductance. Allow less than 1 cm of total lead length for each capacitor between the bypassed pin and the ground plane. 4) Treat the timing capacitor, C_T, like a bypass capacitor.

Error Amplifier Circuit

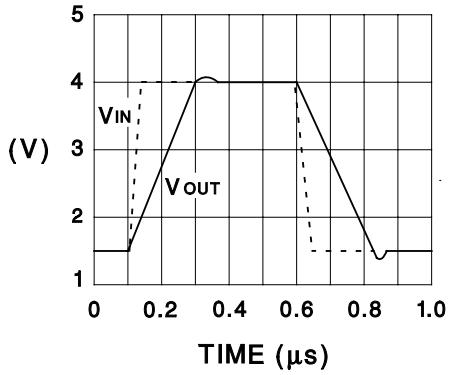
Simplified Schematic



Open Loop Frequency Response

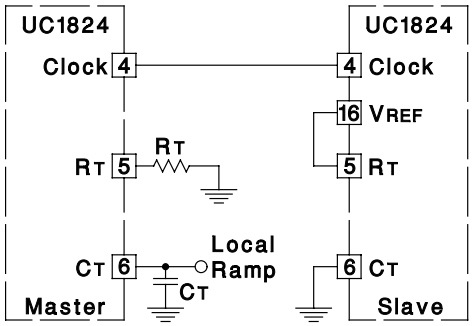


Unity Gain Slew Rate

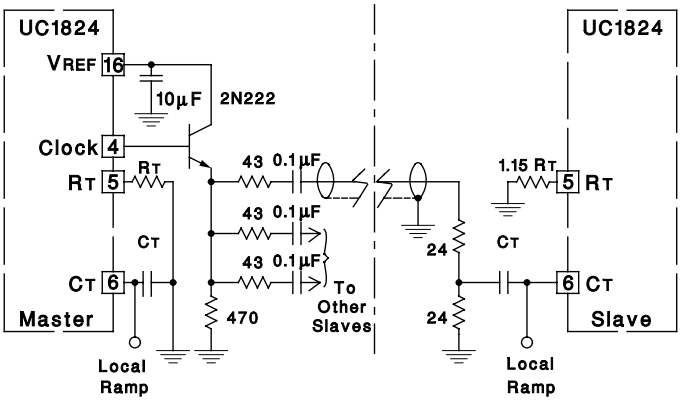


Synchronized Operation

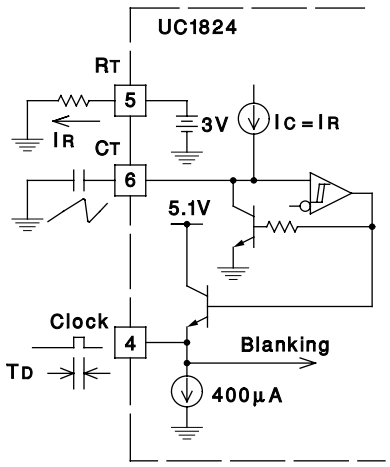
Two Units in Close Proximity



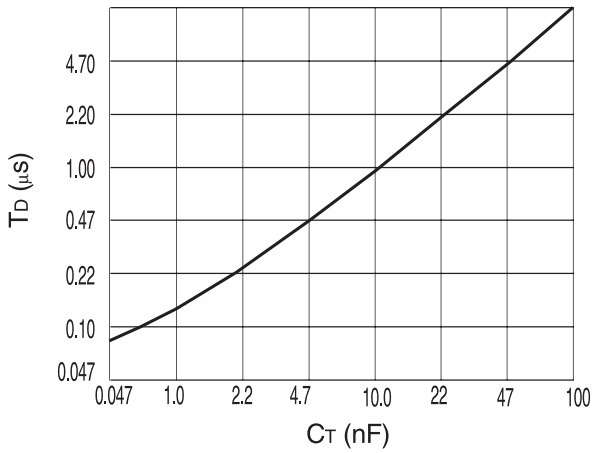
Generalized Synchronization



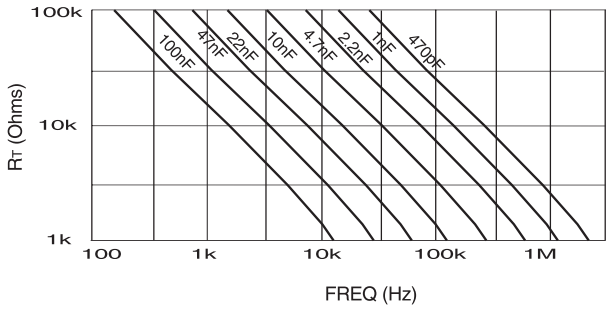
Oscillator Circuit



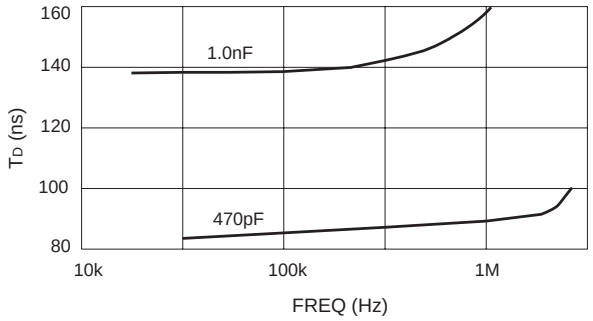
Primary Output Deadtime vs CT (3k ≤ RT ≤ 100k)



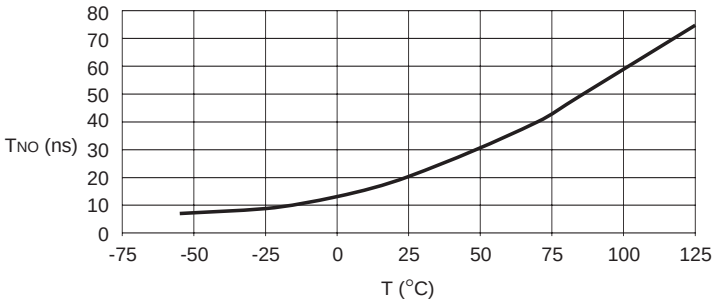
Timing Resistance vs Frequency



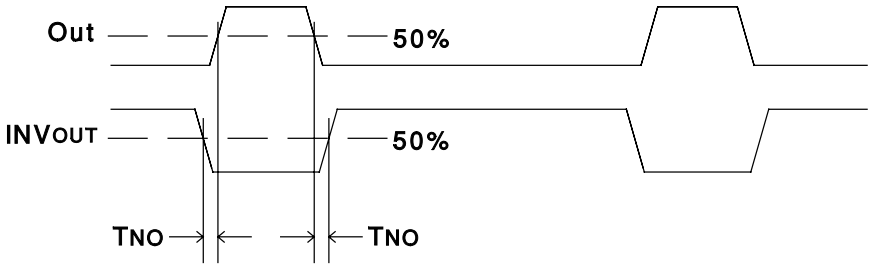
Primary Output Deadtime vs Frequency



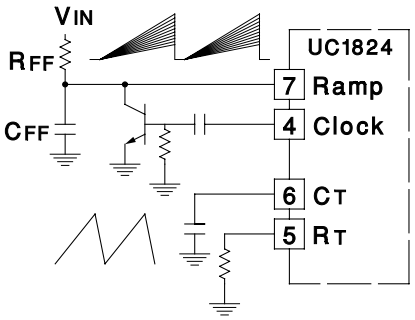
Typical Non-Overlap Time (TNO) Over Temperature



Non-Overlap Time (TNO)

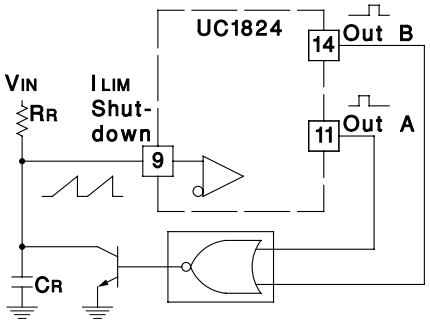


Forward Technique for Off-Line Voltage Mode Application



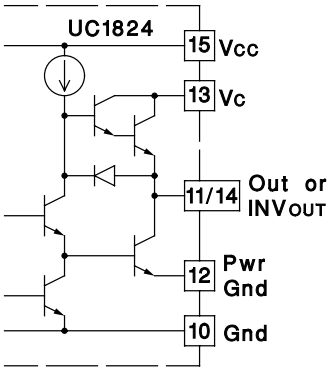
Constant Volt-Second Clamp Circuit

The circuit shown here will achieve a constant volt-second product clamp over varying input voltages. The ramp generator components, RT and CR are chosen so that the ramp at Pin 9 crosses the 1V threshold at the same time the desired maximum volt-second product is reached. The delay through the functional nor block must be such that the ramp capacitor can be completely discharged during the minimum deadtime.

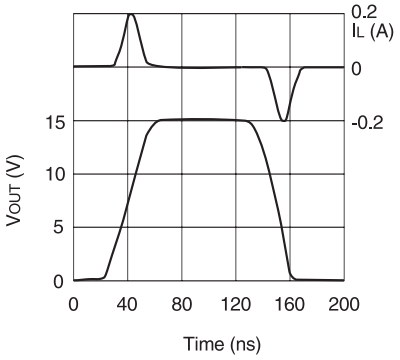


Output Section

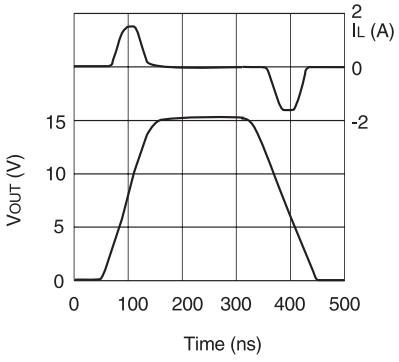
Simplified Schematic



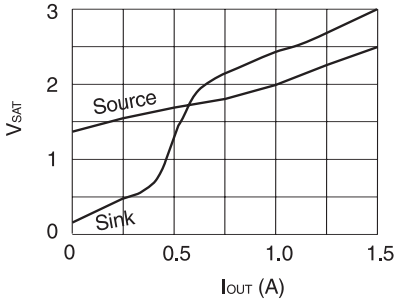
Rise/Fall Time (CL=1nF)



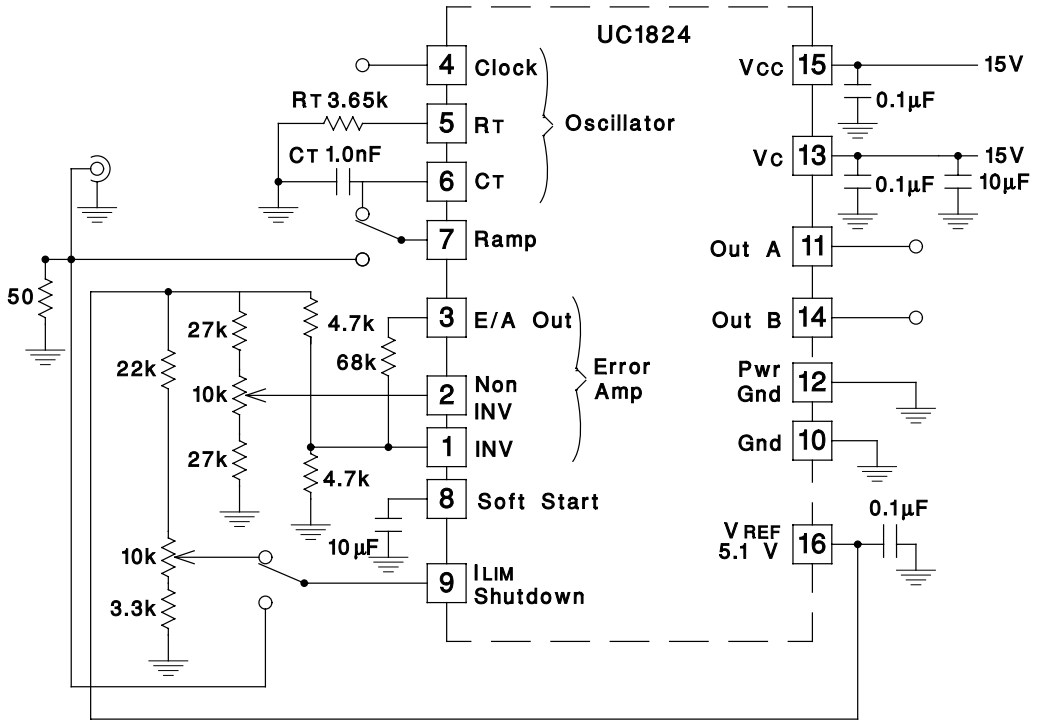
Rise/Fall Time (CL=10nF)



Saturation Curves



Open Loop Laboratory Test Fixture



This test fixture is useful for exercising many of the UC1824's functions and measuring their specifications.

As with any wideband circuit, careful grounding and bypass procedures should be followed. The use of a ground plane is highly recommended.

UNITRODE CORPORATION
7 CONTINENTAL BLVD. • MERRIMACK, NH 03054
TEL. (603) 424-2410 • FAX (603) 424-3460

IMPORTANT NOTICE

Texas Instruments and its subsidiaries (TI) reserve the right to make changes to their products or to discontinue any product or service without notice, and advise customers to obtain the latest version of relevant information to verify, before placing orders, that information being relied on is current and complete. All products are sold subject to the terms and conditions of sale supplied at the time of order acknowledgement, including those pertaining to warranty, patent infringement, and limitation of liability.

TI warrants performance of its semiconductor products to the specifications applicable at the time of sale in accordance with TI's standard warranty. Testing and other quality control techniques are utilized to the extent TI deems necessary to support this warranty. Specific testing of all parameters of each device is not necessarily performed, except those mandated by government requirements.

CERTAIN APPLICATIONS USING SEMICONDUCTOR PRODUCTS MAY INVOLVE POTENTIAL RISKS OF DEATH, PERSONAL INJURY, OR SEVERE PROPERTY OR ENVIRONMENTAL DAMAGE ("CRITICAL APPLICATIONS"). TI SEMICONDUCTOR PRODUCTS ARE NOT DESIGNED, AUTHORIZED, OR WARRANTED TO BE SUITABLE FOR USE IN LIFE-SUPPORT DEVICES OR SYSTEMS OR OTHER CRITICAL APPLICATIONS. INCLUSION OF TI PRODUCTS IN SUCH APPLICATIONS IS UNDERSTOOD TO BE FULLY AT THE CUSTOMER'S RISK.

In order to minimize risks associated with the customer's applications, adequate design and operating safeguards must be provided by the customer to minimize inherent or procedural hazards.

TI assumes no liability for applications assistance or customer product design. TI does not warrant or represent that any license, either express or implied, is granted under any patent right, copyright, mask work right, or other intellectual property right of TI covering or relating to any combination, machine, or process in which such semiconductor products or services might be or are used. TI's publication of information regarding any third party's products or services does not constitute TI's approval, warranty or endorsement thereof.

Copyright © 1999, Texas Instruments Incorporated